

10731109\_CLS.txt  
Most Frequently Occurring Classifications of Patents Returned  
From A Search of 10/731,109 on September 02, 2005

Combined Classifications

9	365/230.06
6	257/E21.648
6	365/201
6	365/203
5	365/149
5	365/230.03
5	365/51
4	257/E21.582
3	257/296
3	257/E21.011
3	257/E21.166
3	257/E21.223
3	257/E21.309
3	257/E21.433
3	257/E21.437
3	257/E21.549
3	257/E21.551
3	257/E21.561
3	257/E27.089
3	365/154
3	365/189.05
3	365/200
3	365/207
3	365/208
3	365/222
3	365/49
3	438/692
3	438/705
3	438/753
2	216/38
2	216/87
2	257/773
2	257/776
2	257/E21.646
2	257/E23.144
2	365/189.01
2	365/189.11
2	365/190
2	365/205
2	365/210
2	365/230.01
2	365/230.09
2	365/233
2	365/63

Titles of Most Frequently Occurring Classifications of Patents Returned  
From A Search of 10/731,109 on September 02, 2005

- 9 365/230.06 (3 OR, 6 XR)  
Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL  
365/230.01 ADDRESSING  
365/230.06 .Particular decoder or driver circuit
- 6 365/201 (6 OR, 0 XR)  
Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL  
365/189.01 READ/WRITE CIRCUIT  
365/201 .Testing
- 6 365/203 (1 OR, 5 XR)  
Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL  
365/189.01 READ/WRITE CIRCUIT  
365/203 .Precharge
- 5 365/149 (0 OR, 5 XR)  
Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL  
365/129 SYSTEMS USING PARTICULAR ELEMENT  
365/149 .Capacitors
- 5 365/230.03 (0 OR, 5 XR)  
Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL  
365/230.01 ADDRESSING  
365/230.03 .Plural blocks or banks
- 5 365/51 (1 OR, 4 XR)  
Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL  
365/51 FORMAT OR DISPOSITION OF ELEMENTS

PLUS Search Results for S/N 10/731,109, Searched September 02, 2005 (Top 50)

The Patent Linguistics Utility System (PLUS) is a USPTO automated search system for U.S. Patents from 1971 to the present. PLUS is a query-by-example search system which produces a list of patents that are most closely related linguistically to the application searched. This search was prepared by the staff of the Scientific and Technical Information Center, SIRA.

6136642  
6261964  
6309975  
6461967  
4914502  
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Fri, 2 Sep 2005, 2:23:53 PM EST

Edit an existing query or  
compose a new query in the  
Search Query Display.

**Search Query Display**

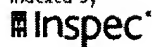
Select a search number (#)  
to:

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

**Recent Search Queries**

- #1 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout <in>metadata )
- #2 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout <in>metadata )
- #3 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout and dram<in>metadata )
- #4 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout and dram<in>metadata )
- #5 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout and dram and trench<in>metadata )
- #6 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout and dram and trench<in>metadata )
- #7 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout and dram and trench<in>metadata )
- #8 ( (bit line) or bitline<in>metadata ) <and> ( (word line) or wordline<in>metadata ) <and> ( layout and dram and trench<in>metadata )

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